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**Package Options Include Plastic** Small-Outline (D) Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

#### description

These devices contain four independent 2-input exclusive-OR gates. They perform the Boolean function  $Y = A \oplus B$  or  $Y = \overline{AB} + A\overline{B}$  in positive logic.

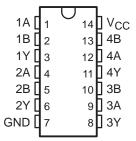
A common application is as a true/complement element. If one of the inputs is low, the other input is reproduced in true form at the output. If one of the inputs is high, the signal on the other input is reproduced inverted at the output.

The SN54HC86 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74HC86 is characterized for operation from -40°C to 85°C.

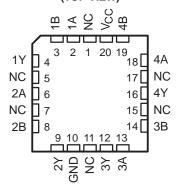
**FUNCTION TABLE** (each gate)

| INP | UTS | OUTPUT |
|-----|-----|--------|
| Α   | В   | Y      |
| L   | L   | L      |
| L   | Н   | н      |
| Н   | L   | н      |
| Н   | Н   | L      |

#### SN54HC86 . . . J OR W PACKAGE SN74HC86 . . . D. N. OR PW PACKAGE (TOP VIEW)

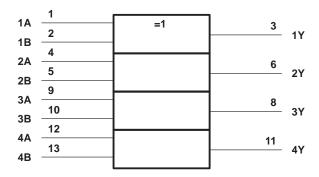


#### SN54HC86...FK PACKAGE (TOP VIEW)



NC - No internal connection

# logic symbol<sup>†</sup>



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, N, PW, and W packages.



testing of all parameters.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



unless otherwise noted. On all other products, production

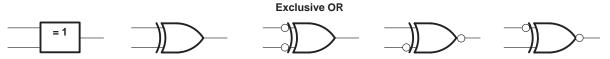
processing does not necessarily include testing of all parameters.

# SN54HC86, SN74HC86 QUADRUPLE 2-INPUT EXCLUSIVE-OR GATES

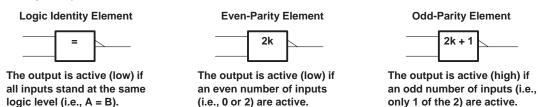
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### exclusive-OR logic

An exclusive-OR gate has many applications, some of which can be represented better by alternative logic symbols.



These are five equivalent exclusive-OR symbols valid for an 'HC86 gate in positive logic; negation may be shown at any two ports.



## absolute maximum ratings over operating free-air temperature range<sup>†</sup>

| Supply voltage range, V <sub>CC</sub>   |            | 0.5 V to 7 V   |
|---|------------|----------------|
| Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) (see                            | e Note 1)  | ±20 mA         |
| Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> |            |                |
| Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$                                  |            |                |
| Continuous current through V <sub>CC</sub> or GND   |            | ±50 mA         |
| Package thermal impedance, $\theta_{JA}$ (see Note 2):  | D package  | 127°C/W        |
| •••   | N package  | 78°C/W         |
|   | PW package | 170°C/W        |
| Storage temperature range, T <sub>stq</sub>   |            | -65°C to 150°C |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

## recommended operating conditions (see Note 3)

|                |   |                         | S    | SN54HC86 |      | SN74HC86 |     |      | UNIT |
|----------------|---|-------------------------|------|----------|------|----------|-----|------|------|
|                |   |                         | MIN  | NOM      | MAX  | MIN      | NOM | MAX  | UNII |
| Vcc            | Supply voltage                          |                         | 2    | 5        | 6    | 2        | 5   | 6    | V    |
|                |   | V <sub>CC</sub> = 2 V   | 1.5  |          |      | 1.5      |     |      |      |
| ViH            | High-level input voltage                | V <sub>CC</sub> = 4.5 V | 3.15 |          |      | 3.15     |     |      | V    |
|                |   | V <sub>CC</sub> = 6 V   | 4.2  |          |      | 4.2      |     | 0.5  |      |
|                | / <sub>IL</sub> Low-level input voltage | V <sub>CC</sub> = 2 V   | 0    |          | 0.5  | 0        |     | 0.5  |      |
| VIL            |   | V <sub>CC</sub> = 4.5 V | 0    |          | 1.35 | 0        |     | 1.35 | V    |
|                |   | V <sub>CC</sub> = 6 V   | 0    |          | 1.8  | 0        |     | 1.8  |      |
| ٧ı             | Input voltage                           |                         | 0    |          | VCC  | 0        |     | VCC  | V    |
| Vo             | Output voltage                          |                         | 0    |          | VCC  | 0        |     | VCC  | V    |
|                | Input transition (rise and fall) time   | V <sub>CC</sub> = 2 V   | 0    |          | 1000 | 0        |     | 1000 |      |
| t <sub>t</sub> |   | V <sub>CC</sub> = 4.5 V | 0    |          | 500  | 0        |     | 500  | ns   |
|                |   | V <sub>CC</sub> = 6 V   | 0    |          | 400  | 0        |     | 400  |      |
| TA             | Operating free-air temperature          |                         | -55  |          | 125  | -40      |     | 85   | °C   |

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS      |                            | Vaa             | T <sub>A</sub> = 25°C     |       | SN54HC86 |      | SN74HC86 |      | LINIT |       |      |  |
|-----------|----------------------|----------------------------|-----------------|---------------------------|-------|----------|------|----------|------|-------|-------|------|--|
| PARAMETER |                      |                            | VCC             | MIN                       | TYP   | MAX      | MIN  | MAX      | MIN  | MAX   | UNIT  |      |  |
|           |                      |                            | 2 V             | 1.9                       | 1.998 |          | 1.9  |          | 1.9  |       |       |      |  |
|           |                      | $I_{OH} = -20  \mu A$      | 4.5 V           | 4.4                       | 4.499 |          | 4.4  |          | 4.4  |       |       |      |  |
| Voн       | VI = VIH or VIL      |                            | 6 V             | 5.9                       | 5.999 |          | 5.9  |          | 5.9  |       | V     |      |  |
|           |                      | $I_{OH} = -4 \text{ mA}$   | 4.5 V           | 3.98                      | 4.3   |          | 3.7  |          | 3.84 |       |       |      |  |
|           |                      | $I_{OH} = -5.2 \text{ mA}$ | 6 V             | 5.48                      | 5.8   |          | 5.2  |          | 5.34 |       |       |      |  |
|           | VI = VIH or VIL      | Ι <sub>ΟL</sub> = 20 μΑ    | 2 V             |                           | 0.002 | 0.1      |      | 0.1      |      | 0.1   |       |      |  |
|           |                      |                            | 4.5 V           |                           | 0.001 | 0.1      |      | 0.1      |      | 0.1   |       |      |  |
| VOL       |                      |                            | 6 V             |                           | 0.001 | 0.1      |      | 0.1      |      | 0.1   | \ \ \ |      |  |
|           |                      | $I_{OL} = 4 \text{ mA}$    | 4.5 V           |                           | 0.17  | 0.26     |      | 0.4      |      | 0.33  |       |      |  |
|           |                      | ľ                          | I <sub>OL</sub> | $I_{OL} = 5.2 \text{ mA}$ | 6 V   |          | 0.15 | 0.26     |      | 0.4   |       | 0.33 |  |
| II        | $V_I = V_{CC}$ or 0  |                            | 6 V             |                           | ±0.1  | ±100     |      | ±1000    |      | ±1000 | nA    |      |  |
| Icc       | $V_I = V_{CC}$ or 0, | I <sub>O</sub> = 0         | 6 V             |                           |       | 2        |      | 40       |      | 20    | μΑ    |      |  |
| Ci        |                      |                            | 2 V to 6 V      |                           | 3     | 10       |      | 10       |      | 10    | pF    |      |  |

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# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

| PARAMETER        | FROM             | то       | Vaa   | T,  | λ = 25°C | ;   | SN54l | 1C86 | SN74l | 1C86 | UNIT |
|------------------|------------------|----------|-------|-----|----------|-----|-------|------|-------|------|------|
|                  | (INPUT)          | (OUTPUT) | VCC   | MIN | TYP      | MAX | MIN   | MAX  | MIN   | MAX  | UNIT |
|                  |                  | 2 V      |       | 40  | 100      |     | 150   |      | 125   |      |      |
| <sup>t</sup> pd  | A or B           | Υ        | 4.5 V |     | 12       | 20  |       | 30   |       | 25   | ns   |
|                  |                  | 6 V      |       | 10  | 17       |     | 25    |      | 21    |      |      |
| t <sub>t</sub> Y | t <sub>t</sub> Y | 2 V      |       | 28  | 75       |     | 110   |      | 95    |      |      |
|                  |                  | 4.5 V    |       | 8   | 15       |     | 22    |      | 19    | ns   |      |
|                  |                  |          | 6 V   |     | 6        | 13  |       | 19   |       | 16   |      |

## operating characteristics, T<sub>A</sub> = 25°C

|                 | PARAMETER                              | TEST CONDITIONS | TYP | UNIT |
|-----------------|--|-----------------|-----|------|
| C <sub>pd</sub> | Power dissipation capacitance per gate | No load         | 35  | pF   |

#### PARAMETER MEASUREMENT INFORMATION **From Output** Test Input 50% 50% **Under Test Point** $C_L = 50 pF$ tPLH -<sup>t</sup>PHL (see Note A) $v_{OH}$ In-Phase Output **LOAD CIRCUIT** 10% - tPHL VCC 90% Input 90% **Out-of-Phase** Output **VOLTAGE WAVEFORM VOLTAGE WAVEFORMS INPUT RISE AND FALL TIMES** PROPAGATION DELAY AND OUTPUT TRANSITION TIMES

- NOTES: A. C<sub>I</sub> includes probe and test-fixture capacitance.
  - B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub> = 6 ns, t<sub>f</sub> = 6 ns.
  - C. The outputs are measured one at a time with one input transition per measurement.
  - D. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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